

Notice of References Cited	Application/Control No. 10/598,491		Applicant(s)/Patent Under Reexamination OYAMA ET AL.	
	Examiner JOSEPH DEAN, JR		Art Unit 4154	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2007/0140181	06-2007	Channegowda et al.	370/338
*	B	US-7,295,551	11-2007	Leung et al.	370/389
*	C	US-2005/0058100	03-2005	Lee et al.	370/331
*	D	US-2004/0023653	02-2004	O'Neill, Alan	455/432.1
*	E	US-2004/0100951	05-2004	O'Neill, Alan	370/389
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

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	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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	V	
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